

Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination LEE ET AL.

Examiner

Nikolas J. Uhlir

Applicant(s)/Patent Under Reexamination LEE ET AL.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6387538	05-2002	Lee et al.	428/632
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NON-PATENT DOCUMENTS

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